

Notice of References Cited	Application/Control No. 10/572,607		Applicant(s)/Patent Under Reexamination GEIER ET AL.	
	Examiner LEE D. WILSON		Art Unit 3727	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,578,837 B1	06-2003	Blank et al.	269/6
*	B	US-6,585,243 B1	07-2003	Li, Tsung-Hsiang	269/6
*	C	US-6,655,670 B1	12-2003	Liou, Ferng-Jong	269/6
*	D	US-2005/0082728 A1	04-2005	Cicenas et al.	269/006
*	E	US-6,929,253 B2	08-2005	Marks, Joel	269/6
*	F	US-7,017,894 B1	03-2006	Lin, Chian Ling	269/6
*	G	US-7,172,183 B1	02-2007	Yang, Chung Cheng	269/6
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.